50A

# International TOR Rectifier

## **AUTOMOTIVE GRADE**

# AUIRLR3636

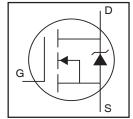
HEXFET® Power MOSFET

#### **Features**

- Advanced Process Technology
- Ultra Low On-Resistance
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free, RoHS Compliant
- Automotive Qualified \*

## **Description**

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.



V <sub>DSS</sub>	60V
R <sub>DS(on)</sub> typ.	$5.4 \mathrm{m}\Omega$
max.	$6.8$ m $\Omega$
I <sub>D</sub> (Silicon Limited)	99A①



D (Package Limited)

G	D	S
Gate	Drain	Source

## **Absolute Maximum Ratings**

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature  $(T_A)$  is 25°C, unless otherwise specified.

Symbol	Parameter	Max.	Units	
$I_D @ T_C = 25^{\circ}C$	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited)	99 ①		
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited)	70 ①	Α	
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Package Limited)	50	1	
I <sub>DM</sub>	Pulsed Drain Current ②	396		
P <sub>D</sub> @T <sub>C</sub> = 25°C	Maximum Power Dissipation	143	W	
	Linear Derating Factor	0.95	W/°C	
$V_{GS}$	Gate-to-Source Voltage	±16	V	
E <sub>AS</sub>	Single Pulse Avalanche Energy (Thermally Limited) 3	170	mJ	
I <sub>AR</sub>	Avalanche Current ②	Con Fig 14 15 000 00h	А	
E <sub>AR</sub>	Repetitive Avalanche Energy ©	See Fig.14, 15, 22a, 22b	mJ	
dv/dt	Peak Diode Recovery ④	22	V/ns	
$T_J$	Operating Junction and	-55 to + 175		
T <sub>STG</sub>	Storage Temperature Range	-55 (0 + 175	°C	
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	<b>1</b>	

## Thermal Resistance

Symbol	Symbol Parameter		Max.	Units
$R_{\theta JC}$	Junction-to-Case ®		1.05	
$R_{\theta JA}$	Junction-to-Ambient (PCB Mount) ®		50	°C/W
$R_{\theta JA}$	Junction-to-Ambient		110	

HEXFET® is a registered trademark of International Rectifier.

<sup>\*</sup>Qualification standards can be found at http://www.irf.com/



## Static Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
V <sub>(BR)DSS</sub>	Drain-to-Source Breakdown Voltage	60			V	$V_{GS} = 0V, I_{D} = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient		0.07		V/°C	Reference to 25°C, I <sub>D</sub> = 5mA <sup>②</sup>
В	Static Drain-to-Source On-Resistance		5.4	6.8	m()	$V_{GS} = 10V, I_{D} = 50A$ ③
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance		6.6	8.3	11152	$V_{GS} = 4.5V, I_D = 50A $ $\bigcirc$
$V_{GS(th)}$	Gate Threshold Voltage	1.0		2.5	V	$V_{DS} = V_{GS}$ , $I_D = 100\mu A$
gfs	Forward Transconductance	31			S	$V_{DS} = 25V, I_{D} = 50A$
R <sub>G(int)</sub>	Internal Gate Resistance		0.6		Ω	
I <sub>DSS</sub>	Drain-to-Source Leakage Current			20		$V_{DS} = 60V, V_{GS} = 0V$
				250	μΑ	$V_{DS} = 60V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I <sub>GSS</sub>	Gate-to-Source Forward Leakage			100	nA	V <sub>GS</sub> = 16V
	Gate-to-Source Reverse Leakage			-100	I IIA	$V_{GS} = -16V$

## Dynamic Electrical Characteristics @ $T_J = 25$ °C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
$Q_g$	Total Gate Charge		33	49		$I_D = 50A$
$Q_{gs}$	Gate-to-Source Charge		11			$V_{DS} = 30V$
$Q_{gd}$	Gate-to-Drain ("Miller") Charge		15		nC	V <sub>GS</sub> = 4.5V ⑤
Q <sub>sync</sub>	Total Gate Charge Sync. (Q <sub>g</sub> - Q <sub>gd</sub> )		18		Ī	$I_D = 50A$ , $V_{DS} = 0V$ , $V_{GS} = 4.5V$
t <sub>d(on)</sub>	Turn-On Delay Time		45			$V_{DD} = 39V$
t <sub>r</sub>	Rise Time		216		Ī	$I_D = 50A$
t <sub>d(off)</sub>	Turn-Off Delay Time		43		ns	$R_G = 7.5 \Omega$
t <sub>f</sub>	Fall Time		69		Ī	V <sub>GS</sub> = 4.5V ⑤
C <sub>iss</sub>	Input Capacitance		3779			$V_{GS} = 0V$
C <sub>oss</sub>	Output Capacitance		332			$V_{DS} = 50V$
C <sub>rss</sub>	Reverse Transfer Capacitance		163		pF	f = 1.0MHz
C <sub>oss</sub> eff. (ER)	Effective Output Capacitance (Energy Related)		437		Ī	$V_{GS} = 0V$ , $V_{DS} = 0V$ to 48V ②,See Fig.11
C <sub>oss</sub> eff. (TR)	Effective Output Capacitance (Time Related) ©		636		Ī	V <sub>GS</sub> = 0V, V <sub>DS</sub> = 0V to 48V ©

## **Diode Characteristics**

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
I <sub>s</sub>	Continuous Source Current			99 ①		MOSFET symbol
	(Body Diode)			99 🕕	Α	showing the
I <sub>SM</sub>	Pulsed Source Current			396	_ A	integral reverse
	(Body Diode) ②			390		p-n junction diode.
$V_{SD}$	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C, I_S = 50A, V_{GS} = 0V $
t <sub>rr</sub>	Reverse Recovery Time		27		no	$T_J = 25$ °C $V_R = 51V$ ,
			32		ns	$T_{\rm J} = 125^{\circ}{\rm C}$ $I_{\rm F} = 50{\rm A}$
Q <sub>rr</sub>	Reverse Recovery Charge	I	31		~~	$T_J = 25^{\circ}C$ di/dt = 100A/ $\mu$ s $^{\circ}$
			43			$T_J = 125^{\circ}C$
I <sub>RRM</sub>	Reverse Recovery Current		2.1		Α	$T_J = 25^{\circ}C$
t <sub>on</sub>	Forward Turn-On Time	Intrins	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)			

## Notes:

- ① Calcuted continuous current based on maximum allowable junction temperature Bond wire current limit is 50A. Note that current limitation arising from heating of the device leds may occur with some lead mounting arrangements.
- ② Repetitive rating; pulse width limited by max. junction temperature.
- $\P$  I<sub>SD</sub>  $\leq$  50A, di/dt  $\leq$  1109 A/ $\mu$ s, V<sub>DD</sub>  $\leq$  V<sub>(BR)DSS</sub>, T<sub>J</sub>  $\leq$  175°C.

- ⑤ Pulse width  $\leq 400 \mu s$ ; duty cycle  $\leq 2\%$ .
- $\ \ \, \ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \$   $\$   $\ \$   $\ \$   $\$   $\ \$   $\$   $\ \$   $\$   $\$   $\$   $\ \$   $\$
- $\ \ \,$  C  $_{oss}$  eff. (ER) is a fixed capacitance that gives the same energy as C  $_{oss}$  while V  $_{DS}$  is rising from 0 to 80% V  $_{DSS}.$
- When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniquea refer to application note # AN- 994 echniques refer to application note #AN-994.

## Qualification Information<sup>†</sup>

		Automotive (per AEC-Q101) ††			
Qualificat	tion Level	Comments: This part number(s) passed Automotive qualification level is granted extension of the higher Automotive level.			
Moisture	Sensitivity Level	D-PAK MSL1			
	Machine Model	Class M4 (+/- 600V) <sup>†††</sup>			
			AEC-Q101-002		
FCD	Human Body Model		Class H1C (+/- 2000V) <sup>†††</sup>		
ESD		AEC-Q101-001			
	Charged Device	Class C5 (+/- 2000V) <sup>†††</sup>			
	Model		AEC-Q101-005		
RoHS Co	mpliant	Yes			

<sup>†</sup> Qualification standards can be found at International Rectifier's web site: http://www.irf.com/

<sup>††</sup> Exceptions (if any) to AEC-Q101 requirements are noted in the qualification report.

<sup>†††</sup> Highest passing voltage.

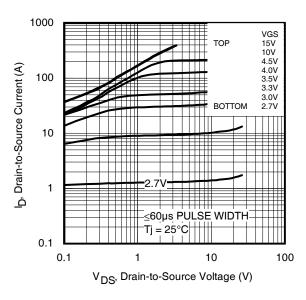


Fig 1. Typical Output Characteristics

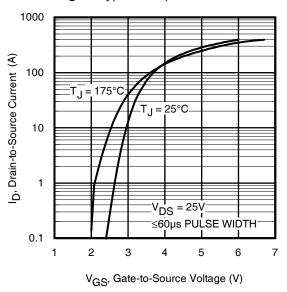


Fig 3. Typical Transfer Characteristics

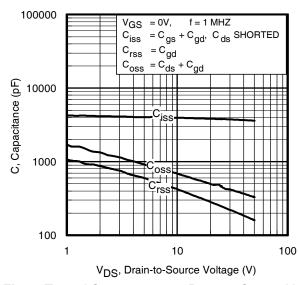


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

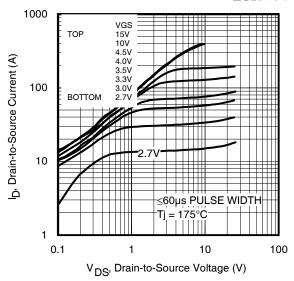


Fig 2. Typical Output Characteristics

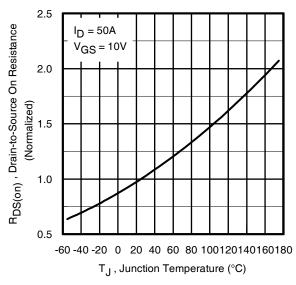
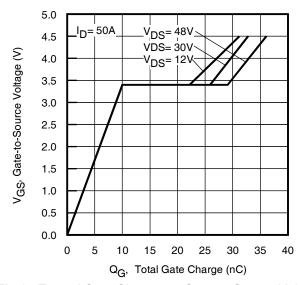
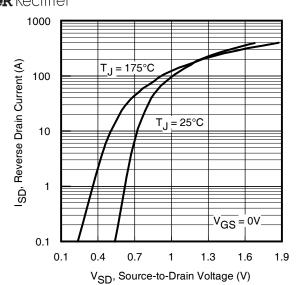


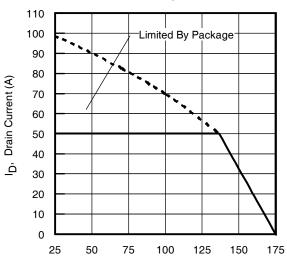
Fig 4. Normalized On-Resistance vs. Temperature



**Fig 6.** Typical Gate Charge vs. Gate-to-Source Voltage www.irf.com

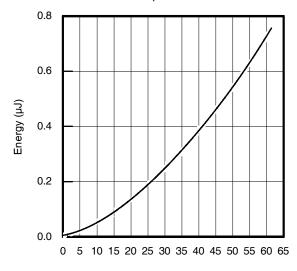


**Fig 7.** Typical Source-Drain Diode Forward Voltage



T<sub>C</sub>, Case Temperature (°C) **Fig 9.** Maximum Drain Current vs.

Case Temperature



V<sub>DS,</sub> Drain-to-Source Voltage (V) **Fig 11.** Typical C<sub>OSS</sub> Stored Energy

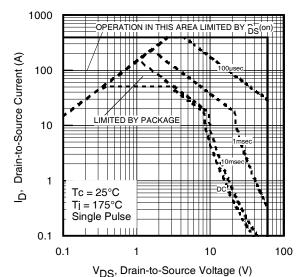


Fig 8. Maximum Safe Operating Area

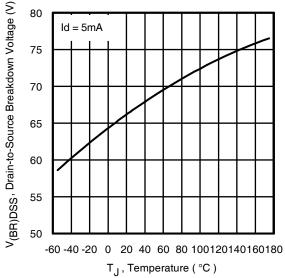


Fig 10. Drain-to-Source Breakdown Voltage

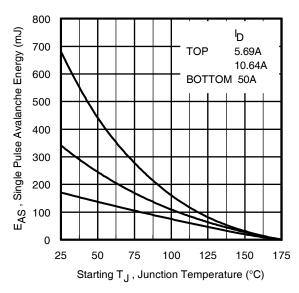


Fig 12. Maximum Avalanche Energy vs. DrainCurrent

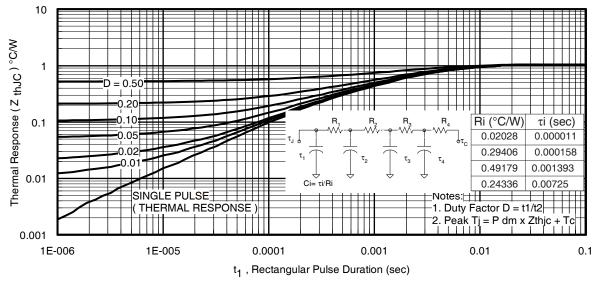


Fig 13. Maximum Effective Transient Thermal Impedance, Junction-to-Case

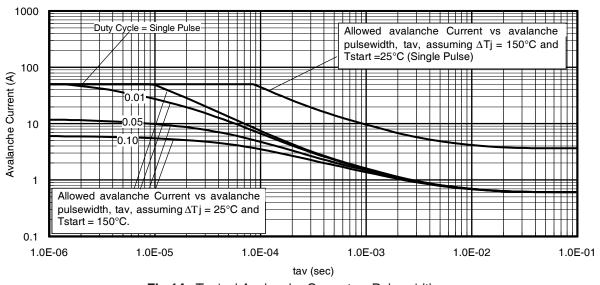


Fig 14. Typical Avalanche Current vs. Pulsewidth

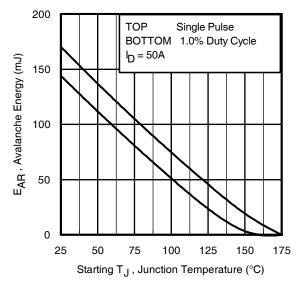


Fig 15. Maximum Avalanche Energy vs. Temperature

6

# Notes on Repetitive Avalanche Curves , Figures 14, 15: (For further info, see AN-1005 at www.irf.com)

- 1. Avalanche failures assumption:
  - Purely a thermal phenomenon and failure occurs at a temperature far in excess of  $T_{jmax}$ . This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long  $asT_{jmax}$  is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 16a, 16b.
- 4. P<sub>D (ave)</sub> = Average power dissipation per single avalanche pulse.
- BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. I<sub>av</sub> = Allowable avalanche current.
- 7.  $\Delta T$  = Allowable rise in junction temperature, not to exceed  $T_{jmax}$  (assumed as 25°C in Figure 14, 15).

t<sub>av =</sub> Average time in avalanche.

D = Duty cycle in avalanche =  $t_{av} \cdot f$ 

 $Z_{th,JC}(D, t_{av})$  = Transient thermal resistance, see Figures 13)

$$\begin{split} P_{D \; (ave)} &= 1/2 \; (\; 1.3 \cdot BV \cdot I_{av}) = \triangle T / \; Z_{thJC} \\ I_{av} &= 2\triangle T / \; [1.3 \cdot BV \cdot Z_{th}] \\ E_{AS \; (AR)} &= P_{D \; (ave)} \cdot t_{av} \end{split}$$

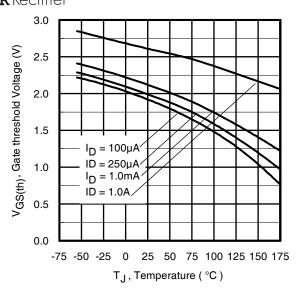


Fig 16. Threshold Voltage vs. Temperature

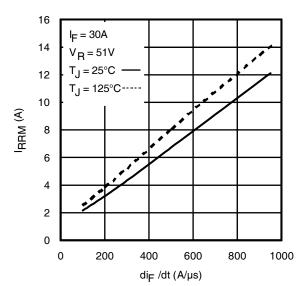


Fig. 18 - Typical Recovery Current vs. dif/dt

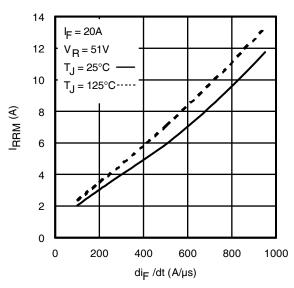


Fig. 17 - Typical Recovery Current vs. di<sub>f</sub>/dt

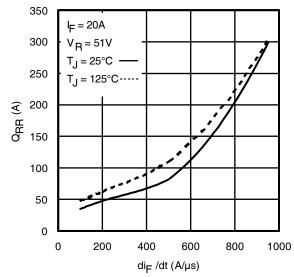


Fig. 19 - Typical Stored Charge vs. dif/dt

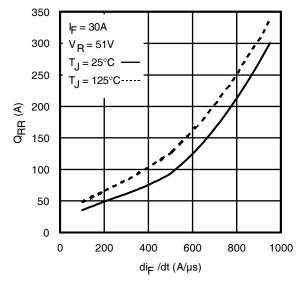
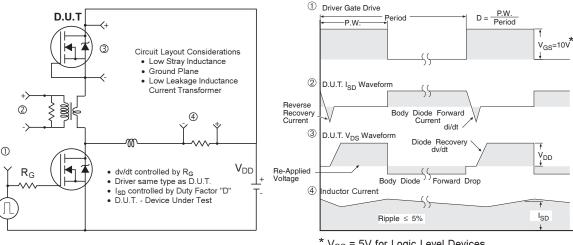


Fig. 20 - Typical Stored Charge vs. dif/dt



\*  $V_{GS}$  = 5V for Logic Level Devices

Fig 21. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

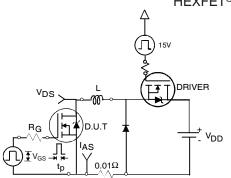


Fig 22a. Unclamped Inductive Test Circuit

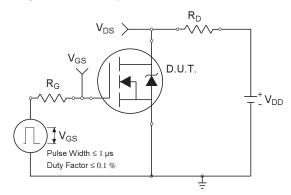


Fig 23a. Switching Time Test Circuit

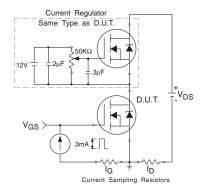


Fig 24a. Gate Charge Test Circuit

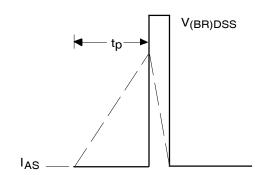


Fig 22b. Unclamped Inductive Waveforms

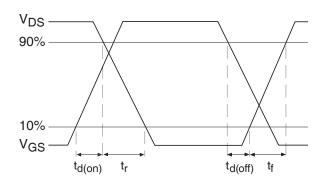


Fig 23b. Switching Time Waveforms

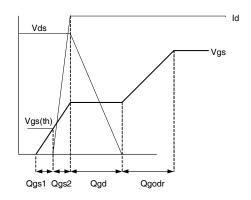
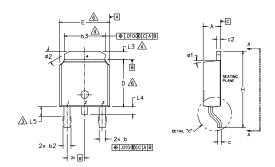


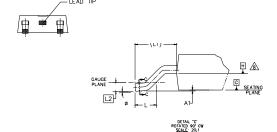
Fig 24b. Gate Charge Waveform

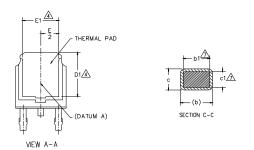


## D-Pak (TO-252AA) Package Outline

Dimensions are shown in millimeters (inches)







#### NOTES:

- 1.- DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2.- DIMENSION ARE SHOWN IN INCHES [MILLIMETERS].
- 3- LEAD DIMENSION UNCONTROLLED IN L5.
- A- DIMENSION D1, E1, L3 & b3 ESTABLISH A MINIMUM MOUNTING SURFACE FOR THERMAL PAD.
- 5.— SECTION C-C DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN .005 AND 0.10 [0.13 AND 0.25] FROM THE LEAD TIP.
- ⚠— DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005 [0.13] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
- A- DIMENSION 61 & c1 APPLIED TO BASE METAL ONLY.
- A- DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
- 9.- OUTLINE CONFORMS TO JEDEC OUTLINE TO-252AA.

S		Ŋ			
M B O	MILLIM	ETERS	S INCHES T		O T E S
L	MIN,	MAX.	MIN.	MAX.	S
Α	2.18	2.39	.086	.094	
A1	-	0,13	-	.005	
ь	0.64	0.89	.025	.035	
b1	0.65	0.79	.025	.031	7
b2	0,76	1,14	.030	.045	
b3	4.95	5,46	.195	.215	4
С	0.46	0.61	.018	.024	
c1	0.41	0.56	.016	.022	7
c2	0.46	0.89	.018	.035	
D	5.97	6.22	.235	.245	6
D1	5.21	-	.205	-	4
Ε	6.35	6.73	.250	.265	6
E1	4.32	-	.170	_	4
е	2.29	BSC	.090	BSC	
Н	9.40	10,41	.370	.410	
L	1,40	1.78	.055	.070	
L1	2.74	BSC	.108	REF.	
L2	0.51	BSC	.020 BSC		
L3	0.89	1.27	.035	.050	4
L4	-	1.02	-	.040	
L5	1.14	1.52	.045	.060	3
Ø	0,	10°	0,	10°	
ø1	0.	15*	0.	15*	
ø2	25*	35'	25*	35*	

#### LEAD ASSIGNMENTS

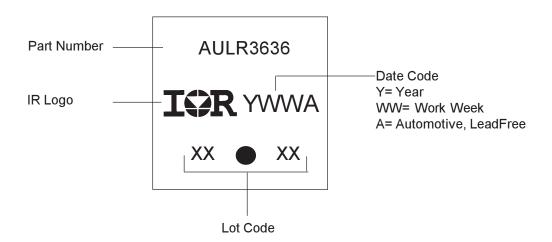
#### **HEXFET**

- 1.- GATE 2.- DRAIN
- 3.- SOURCE
- 4.- DRAIN

### IGBT & CoPAK

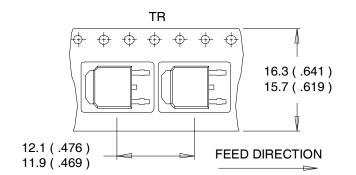
- 1.- GATE
- 2.- COLLECTOR
- 3.- EMITTER 4.- COLLECTOR

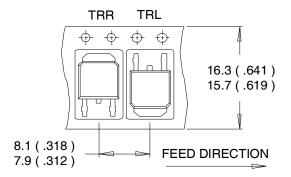
## D-Pak (TO-252AA) Part Marking Information



## D-Pak (TO-252AA) Tape & Reel Information

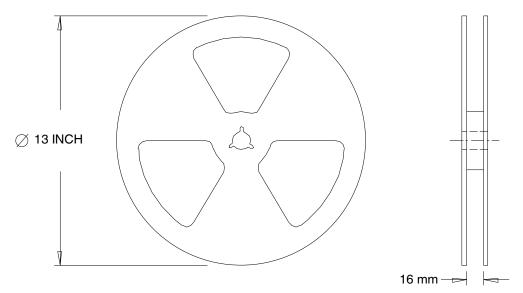
Dimensions are shown in millimeters (inches)





## NOTES:

- 1. CONTROLLING DIMENSION: MILLIMETER.
- 2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
- 3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



## NOTES:

1. OUTLINE CONFORMS TO EIA-481.

## **Ordering Information**

Base part number	Package Type	Standard Pack		Complete Part Number
		Form	Quantity	
AUIRLR3636	Dpak	Tube	75	AUIRLR3636
		Tape and Reel	2000	AUIRLR3636TR
		Tape and Reel Left	3000	AUIRLR3636TRL
		Tape and Reel Right	3000	AUIRLR3636TRR

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